L	Hits	Search Text	DB	Time stamp
Number 1	0	(((((interfer or interfere or interfering	EPO; JPO;	2003/12/11
1	١	or interference or interferometer or		17:59
•		interference or interferometer or interferometrically)	IBM_TDB	17:59
		<pre>and (wafer or substrate)) and (spectra or spectrum or spectral)) and thickness) and</pre>		
		plasma) and film and periodicity		
2	1	(((((interfer or interfere or interfering	EPO; JPO;	2003/12/11
2	_	or interference or interferometer or	IBM TDB	17:59
		interferometric or interferometrically)	IBM_IDB	17.59
		and (wafer or substrate)) and (spectra or		
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		plasma) and film and period\$6		
3	5	(((((interfer or interfere or interfering	EPO; JPO;	2003/12/11
		or interference or interferometer or	IBM TDB	17:59
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		and (wafer or substrate)) and (spectra or		
		spectrum or spectral)) and thickness) and		
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4	6		EPO; JPO;	2003/12/11
		or interference or interferometer or	IBM TDB	18:00
		interferometric or interferometrically)	_	
İ		and (wafer or substrate)) and (spectra or		
		spectrum or spectral)) and thickness) and		
		plasma		
5	96	(((interfer or interfere or interfering	EPO; JPO;	2003/12/11
		or interference or interferometer or	IBM_TDB	18:00
		interferometric or interferometrically)	_	
		and (wafer or substrate)) and (spectra or		
1		spectrum or spectral)) and thickness		
-	243	(356/451).CCLS.	USPAT;	2003/12/11
			US-PGPUB	11:08
-	140	(356/503).CCLS.	USPAT;	2003/12/11
			US-PGPUB	10:56
-	541887		USPAT;	2003/12/11
		interference or interferometer or	US-PGPUB	11:09
		interferometric or interferometrically		
_	629156	wafer or substrate	USPAT;	2003/12/11
			US-PGPUB	11:09
-	316816	spectra or spectrum or spectral	USPAT;	2003/12/11
	05005		US-PGPUB	11:09
-	952925	thickness	USPAT;	2003/12/11
	651540		US-PGPUB	
-	651542	film	USPAT;	2003/12/11
	1205.62	/:	US-PGPUB USPAT;	11:09   2003/12/11
-	130363	(interfer or interfere or interfering or interference or interferometer or	US-PGPUB	11:10
		interference of interferometer of interferometric or interferometrically)	03-FGF0B	11.10
	35342	and (wafer or substrate) ((interfer or interfere or interfere)	USPAT;	2003/12/11
-	35342	interference or interferometer or	US-PGPUB	11:15
		interference of interferometer of interferometric or interferometrically)	03-10100	11.13
		and (wafer or substrate)) and (spectra or		}
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] _	17834	(((interfer or interfere or interfering	USPAT;	2003/12/11
-	17034	or interference or interferometer or	US-PGPUB	18:00 .
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		and (wafer or substrate)) and (spectra or		·
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I _	194845	plasma	USPAT;	2003/12/11
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l _	5505	((((interfer or interfere or interfering	USPAT;	2003/12/11
		or interference or interferometer or	US-PGPUB	18:00
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	4610	1////	TICDAM.	2002/12/14
_	4610	((((interfer or interfere or interfering	USPAT;	2003/12/11
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		plasma) and film		
-	89	· · · · · · · · · · · · · · · · · · ·	USPAT;	2003/12/11
		interfere or interfering or interference	US-PGPUB	11:16
		or interferometer or interferometric or		
		interferometrically) and (wafer or		
		substrate)) and (spectra or spectrum or		
		spectral)) and thickness) and plasma		
_	3267	(((((interfer or interfere or interfering	USPAT;	2003/12/11
		or interference or interferometer or	US-PGPUB	17:59
		interferometric or interferometrically)		
		and (wafer or substrate)) and (spectra or		
		spectrum or spectral)) and thickness) and		.
		plasma) and film and period\$6		
_	282	(((((interfer or interfere or interfering	USPAT;	2003/12/11
		or interference or interferometer or	US-PGPUB	17:59
1		interferometric or interferometrically)		•
		and (wafer or substrate)) and (spectra or		
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		plasma) and film and periodicity		
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	1	interfere or interfering or interference	US-PGPUB	13:48
		or interferometer or interferometric or		
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		spectral)) and thickness) and plasma) and		
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